2SK3133(L),2SK3133(S)

Silicon N Channel MOS FET High Speed Power Switching

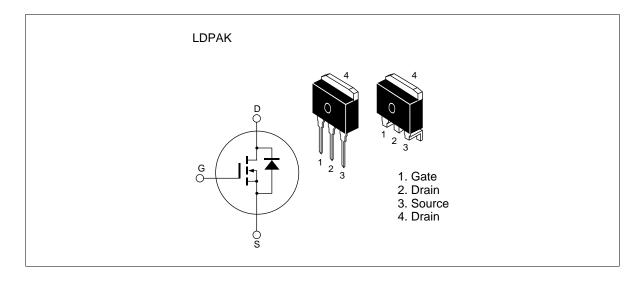
HITACHI

ADE-208-720 (Z) Target Specification 1st. Edition February 1999

Features

- Low on-resistance $R_{DS(on)} = 7 \ m\Omega \ typ.$
- Low drive current
- 4 V gate drive device can be driven from 5 V source

Outline





2SK3133(L),2SK3133(S)

Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	30	V
Gate to source voltage	V_{GSS}	±20	V
Drain current	I _D	50	A
Drain peak current	D(pulse) Note 1	200	A
Body-drain diode reverse drain current	I _{DR}	50	A
Channel dissipation	Pch Note 2	50	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note: 1. PW \leq 10 μ s, duty cycle \leq 1%

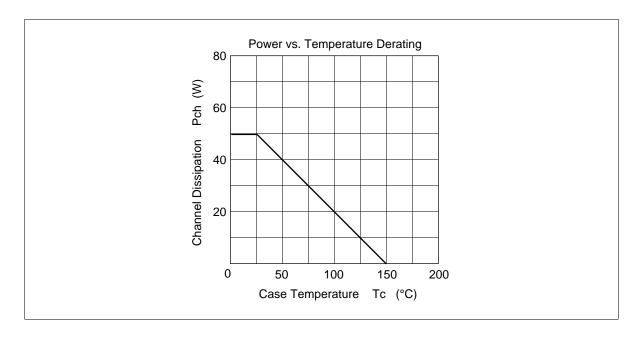
2. Value at Tc = 25°C

Electrical Characteristics ($Ta = 25^{\circ}C$)

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	30	_	_	V	$I_{D} = 10 \text{ mA}, V_{GS} = 0$
Gate to source leak current	I _{GSS}	_	_	±0.1	μΑ	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	_	10	μΑ	$V_{DS} = 30 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.5	V	$I_{\rm D} = 1 \text{mA}, V_{\rm DS} = 10 \text{V}^{ \text{Note 1}}$
Static drain to source on state	R _{DS(on)}	_	7	10	mΩ	$I_D = 25 \text{ A}, V_{GS} = 10 \text{ V}^{\text{Note 1}}$
resistance		_	12	18	mΩ	$I_D = 25 \text{ A}, V_{GS} = 4 \text{ V}^{\text{Note 1}}$
Forward transfer admittance	y _{fs}	TBD	TBD	_	S	$I_D = 25 \text{ A}, V_{DS} = 10 \text{ V}^{\text{Note 1}}$
Input capacitance	Ciss	_	TBD	_	pF	V _{DS} = 10V
Output capacitance	Coss	_	TBD	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	TBD	_	pF	f = 1 MHz
Total gate charge	Qg	_	TBD	_	nc	V _{DD} = 10 V
Gate to source charge	Qgs	_	TBD	_	nc	$V_{GS} = 10 \text{ V}$
Gate to drain charge	Qgd	_	TBD	_	nc	I _D = 50 A
Turn-on delay time	t _{d(on)}	_	TBD	_	ns	$V_{GS} = 10 \text{ V}, I_{D} = 25 \text{ A}$
Rise time	t _r	_	TBD	_	ns	$R_L = 0.4 \Omega$
Turn-off delay time	t _{d(off)}	_	TBD	_	ns	
Fall time	t _f	_	TBD	_	ns	
Body-drain diode forward voltage	V_{DF}	_	TBD	_	V	$I_F = 50 \text{ A}, V_{GS} = 0$
Body-drain diode reverse recovery time	t _{rr}	_	TBD	_	ns	$I_F = 50 \text{ A}, V_{GS} = 0$ diF/ dt = 50 A/ μ s

Note: 1. Pulse test

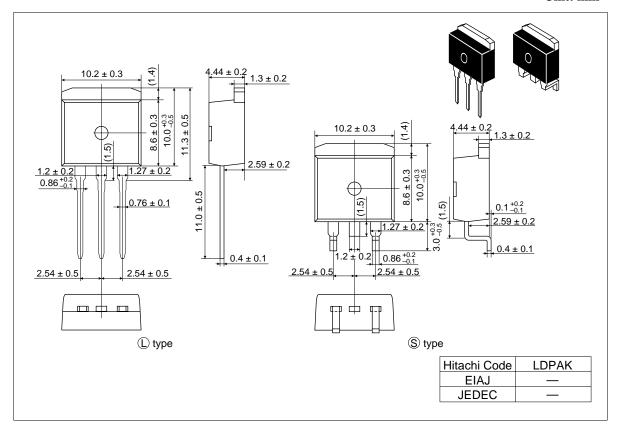
Main Characteristics



2SK3133(L),2SK3133(S)

Package Dimensions

Unit: mm



Cautions

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